

$V_{CE} = 1700\text{ V}$
 $I_C = 75\text{ A}$

IGBT-Die

5SMX 12K1701



Die size: 11.9 x 11.9 mm

Doc. No. 5SYA1619-01 July 03

- Low loss thin IGBT die
- Highly rugged SPT design
- Large front bondable area

Maximum rated values ¹⁾

| Parameter | Symbol | Conditions | min | max | Unit |
|---------------------------|-----------|--|-----|------|--------------------|
| Collector-emitter voltage | V_{CES} | $V_{GE} = 0\text{ V}, T_{vj} \geq 25\text{ °C}$ | | 1700 | V |
| DC collector current | I_C | | | 75 | A |
| Peak collector current | I_{CM} | Limited by T_{vjmax} | | 150 | A |
| Gate-emitter voltage | V_{GES} | | -20 | 20 | V |
| IGBT short circuit SOA | t_{psc} | $V_{CC} = 1300\text{ V}, V_{CEM} \leq 1700\text{ V}$ $V_{GE} \leq 15\text{ V}, T_{vj} \leq 125\text{ °C}$ | | 10 | μs |
| Junction temperature | T_{vj} | | -40 | 150 | $^{\circ}\text{C}$ |

1) Maximum rated values indicate limits beyond which damage to the device may occur

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IGBT characteristic values

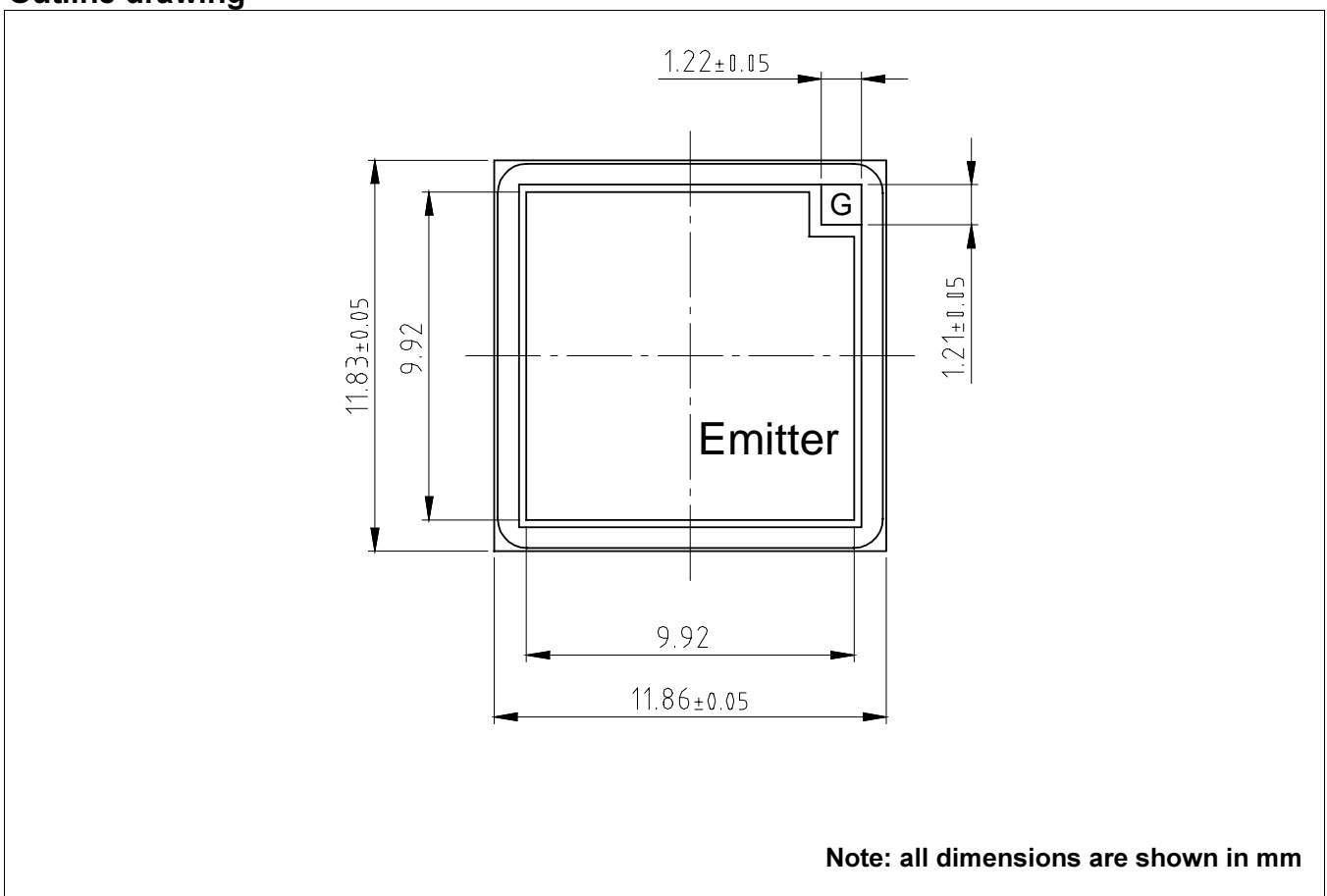
| Parameter | Symbol | Conditions | min | typ | max | Unit | |
|--|----------------------|--|---------------------------|------|-----|----------|---------------|
| Collector (-emitter) breakdown voltage | $V_{(BR)CES}$ | $V_{GE} = 0 \text{ V}$, $I_C = 1 \text{ mA}$, $T_{vj} = 25 \text{ °C}$ | 1700 | | | V | |
| Collector-emitter saturation voltage | $V_{CE \text{ sat}}$ | $I_C = 75 \text{ A}$, $V_{GE} = 15 \text{ V}$ | $T_{vj} = 25 \text{ °C}$ | 2.1 | 2.3 | 2.7 | V |
| | | | $T_{vj} = 125 \text{ °C}$ | | 2.6 | | V |
| Collector cut-off current | I_{CES} | $V_{CE} = 1700 \text{ V}$, $V_{GE} = 0 \text{ V}$ | $T_{vj} = 25 \text{ °C}$ | | | 100 | μA |
| | | | $T_{vj} = 125 \text{ °C}$ | | 800 | | μA |
| Gate leakage current | I_{GES} | $V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$, $T_{vj} = 125 \text{ °C}$ | -500 | | 500 | nA | |
| Gate-emitter threshold voltage | $V_{GE(TO)}$ | $I_C = 3 \text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25 \text{ °C}$ | 4.5 | | 6.5 | V | |
| Gate charge | Q_{ge} | $I_C = 75 \text{ A}$, $V_{CE} = 900 \text{ V}$, $V_{GE} = -15 \dots 15 \text{ V}$ | | 630 | | nC | |
| Input capacitance | C_{ies} | $V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_{vj} = 25 \text{ °C}$ | | 6.9 | | nF | |
| Output capacitance | C_{oes} | | | 0.48 | | | |
| Reverse transfer capacitance | C_{res} | | | 0.29 | | | |
| Internal gate resistance | R_{Gint} | | | 5 | | Ω | |
| Turn-on delay time | $t_{d(on)}$ | $V_{CC} = 900 \text{ V}$, $I_C = 75 \text{ A}$, $R_G = 15 \text{ }\Omega$, $V_{GE} = \pm 15 \text{ V}$, | $T_{vj} = 25 \text{ °C}$ | | 170 | ns | |
| | | | $T_{vj} = 125 \text{ °C}$ | | 180 | | |
| Rise time | t_r | $L_\sigma = 160 \text{ nH}$, inductive load | $T_{vj} = 25 \text{ °C}$ | | 100 | ns | |
| | | | $T_{vj} = 125 \text{ °C}$ | | 110 | | |
| Turn-off delay time | $t_{d(off)}$ | $V_{CC} = 900 \text{ V}$, $I_C = 75 \text{ A}$, $R_G = 15 \text{ }\Omega$, $V_{GE} = \pm 15 \text{ V}$, | $T_{vj} = 25 \text{ °C}$ | | 420 | ns | |
| | | | $T_{vj} = 125 \text{ °C}$ | | 500 | | |
| Fall time | t_f | $L_\sigma = 160 \text{ nH}$, inductive load | $T_{vj} = 25 \text{ °C}$ | | 90 | ns | |
| | | | $T_{vj} = 125 \text{ °C}$ | | 110 | | |
| Turn-on switching energy | E_{on} | $V_{CC} = 900 \text{ V}$, $I_C = 75 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 15 \text{ }\Omega$, $L_\sigma = 160 \text{ nH}$, inductive load, FWD: 5SLX12G1700 | $T_{vj} = 25 \text{ °C}$ | | 18 | mJ | |
| | | | $T_{vj} = 125 \text{ °C}$ | | 25 | | |
| Turn-off switching energy | E_{off} | $V_{CC} = 900 \text{ V}$, $I_C = 75 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 15 \text{ }\Omega$, $L_\sigma = 160 \text{ nH}$, inductive load | $T_{vj} = 25 \text{ °C}$ | | 12 | mJ | |
| | | | $T_{vj} = 125 \text{ °C}$ | | 19 | | |
| Short circuit current | I_{SC} | $t_{psc} \leq 10 \text{ }\mu\text{s}$, $V_{GE} = 15 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $V_{CC} = 1300 \text{ V}$, $V_{CEM} \leq 1700 \text{ V}$ | | 350 | | A | |

Mechanical properties

| Parameter | | | | Unit |
|-----------------------------|---------------------|-------------------------|-------------|------|
| Dimensions | Overall die | L x W | 11.9 x 11.9 | mm |
| | exposed front metal | L x W (except gate pad) | 9.9 x 9.9 | mm |
| | gate pad | L x W | 1.2 x 1.2 | mm |
| | thickness | | 210 ± 15 | µm |
| Metallization ¹⁾ | front | AlSi1 | 4 | µm |
| | back | Al / Ti / Ni / Ag | 1.2 | µm |

1) For assembly instructions refer to : IGBT and Diode chips from ABB Switzerland Ltd, Semiconductors, Doc. No. 5SYA2033-01 April 02.

Outline drawing



This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, Chap. IX.

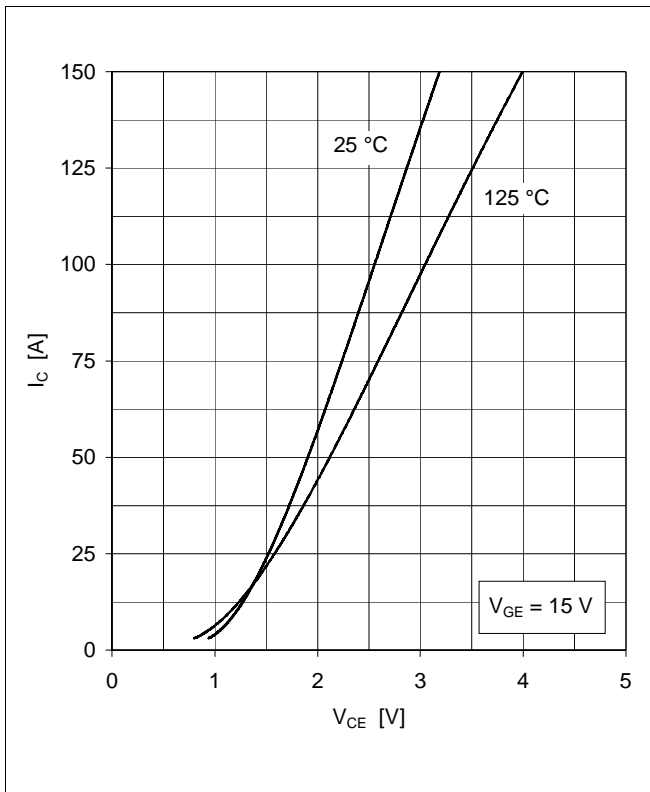


Fig. 1 Typical onstate characteristics

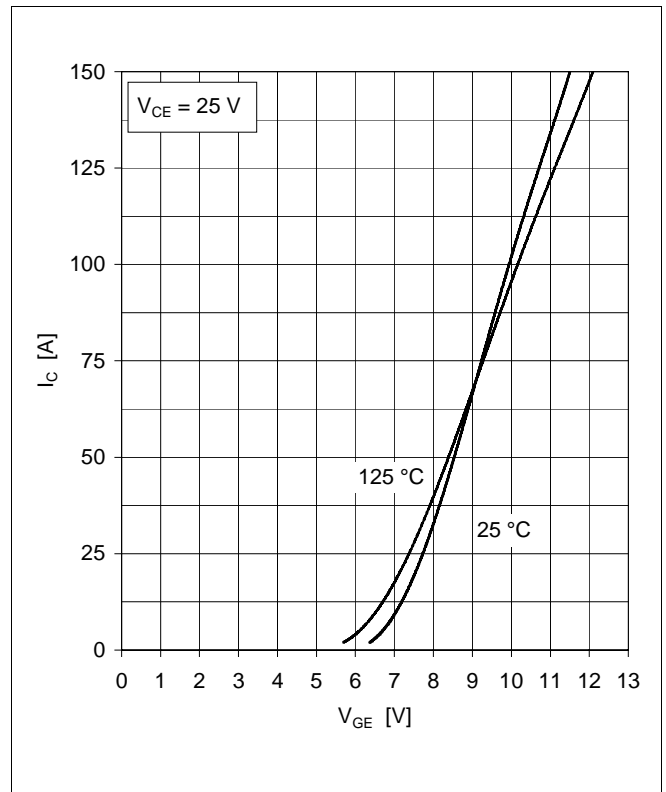


Fig. 2 Typical transfer characteristics

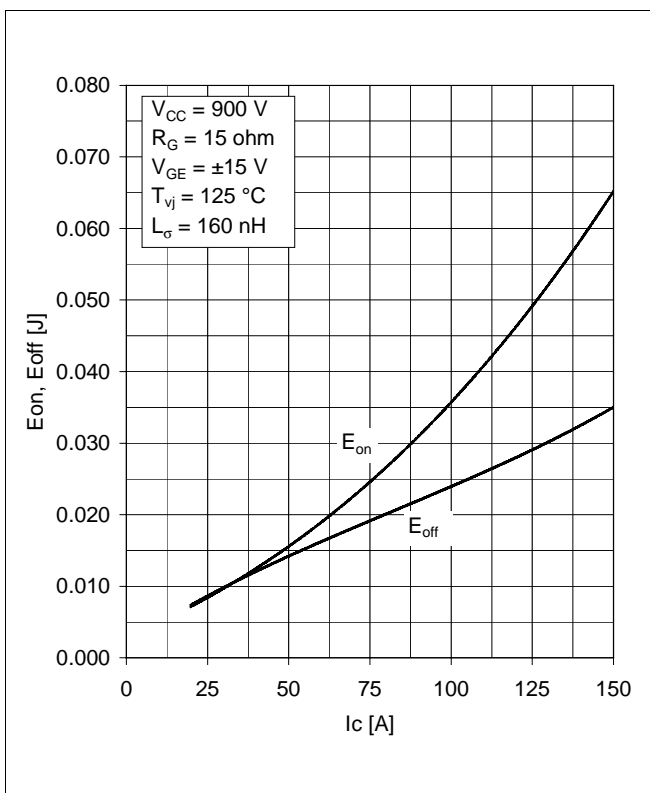


Fig. 3 Typical switching characteristics vs collector current

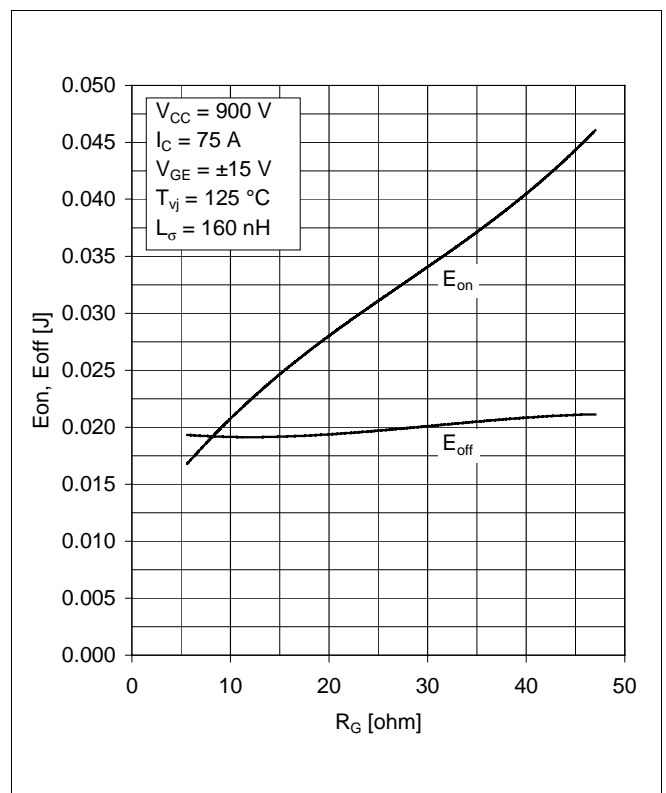


Fig. 4 Typical switching characteristics vs gate resistor

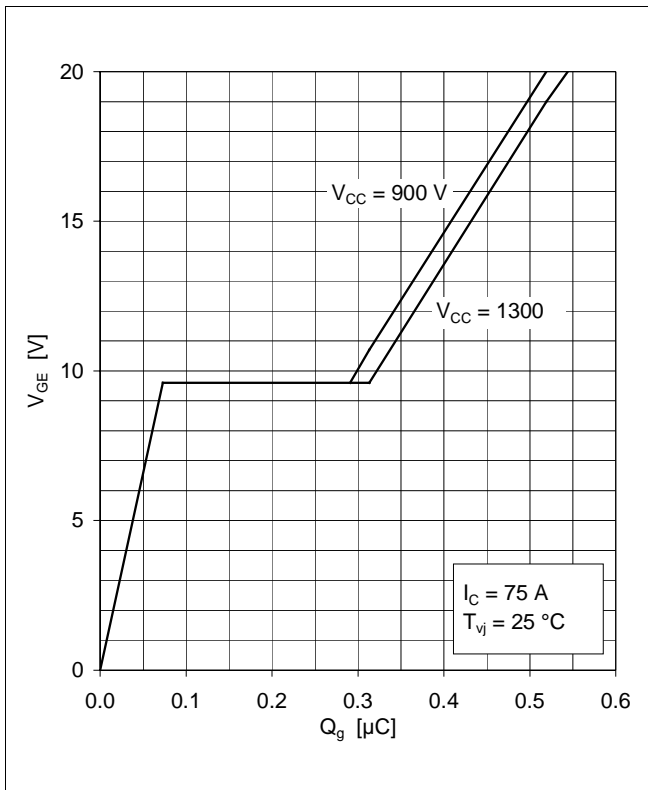


Fig. 5 Typical gate charge characteristics

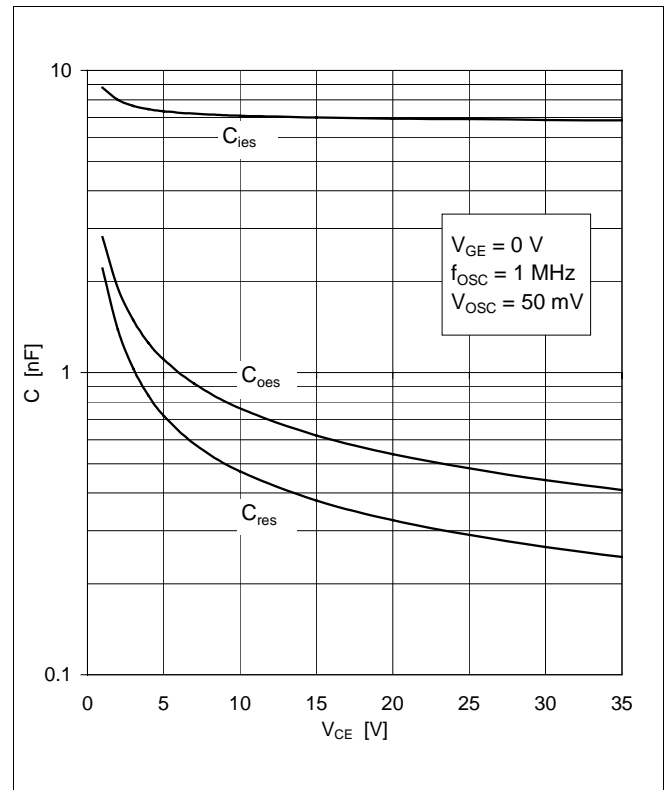


Fig. 6 Typical capacitances vs collector-emitter voltage

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